

2009 SYMPOSIUM ON VLSI CIRCUITS

Welcome to the 2009 Symposium on VLSI Circuits

You are cordially invited to attend the 2009 Symposium on VLSI Circuits, to be held on June 16-18th, 2009, at the Rihga Royal Hotel Kyoto in Kyoto, Japan. We are repeating last year's successful two day overlap with the Technology symposium to foster greater communication between these two key gatherings. The juxtaposition of these two conferences is one of the unique features that distinguish the Symposia from other gatherings. The Symposium brings experts and experienced engineers and scientists from around the world together to discuss the present and future challenges in VLSI Circuits and Technology.

Preceding the Symposium on June 15th, a one-day Short Course will be held. This short course will focus on "Energy Management for Green SoC's and SiP's" where experts will give educational talks on this timely topic in VLSI circuits. On the same day, we have a Workshop on "MM-Wave and Multi-Gigabit Transceivers for High-Speed Wireless Communication." With a single Short Course/ Workshop registration fee you can select to attend either session. The new highlight of the conference is the Luncheon. This year's speaker will be Kosuke Hayakawa from Central Japan Railway Company with a talk on "The Series N700 and the Tokaido Shinkansen". This is a great opportunity to hear from one of the developers of this icon of Japanese transportation on its history and future. This year, the technical program committee reviewed 313 papers and selected 110 papers for presentation covering a range of topics from Digital Circuits and Systems, Memories, Analog, Data Converters, Wireless and Wireline Communications. The core tradition of the Symposium is the paper quality and this year the committee has selected very high quality papers representing the scope of the symposium. We have also invited four distinguished speakers to describe recent advances and new challenges in the areas of Nanotechnology, Medical Electronics, Mobile and Personal Communication and Networking. To complement the formal talks, we have arranged two evening sessions on interesting and provocative subjects to give you an opportunity to participate in the discussions and mix with the participants. The evening sessions explore: "Energy Efficiency: How is 'Green' Implemented in Reality?" and "32nm SoC and Beyond – Reliable or Not?" The rich technical content of the program will undoubtedly interest you, and we certainly hope that the Symposium will be a fruitful and enjoyable experience. This booklet contains the advance program together with forms for the Symposium registration and hotel reservations. Please complete and return these forms or visit our website for online registration at <http://www.vlsisymposium.org/symposia.html>. Although on-site registration will be available at the conference, preregistration will facilitate Symposium planning. We look forward to meeting with you at the Symposium in Kyoto.

CONFERENCE SCHEDULE

Sunday, June 14	8:00-17:00	Registration	
Monday, June 15	7:30-17:00	Registration	
	8:10-12:00	Short Course [Suzaku I] / Workshop [Suzaku III]	
	13:30-17:15	Short Course [Suzaku I] / Workshop [Suzaku III]	
	20:00-22:00	Joint Rump Session [Suzaku I,II]	
Tuesday, June 16	7:30-17:00	Registration	
	8:30-10:05	Session 1	Welcome and Plenary Session I [Suzaku I, II]
	10:30-12:35	Session 2	CDRs and Limiting Amplifiers [Suzaku I]
		Session 3	Non-Volatile and Fuse Memories [Suzaku II]
		Session 4	Biomedical and Personal Technology [Suzaku III]
	12:35-13:55	Lunch	
	13:55-16:00	Session 5	Transmitters and Receivers [Suzaku I]
		Session 6	Biomedical and Sensors [Suzaku III]
	13:55-15:10	Special Session [Shunju I, II]	
	16:10-17:50	Session 7	Sigma-Delta ADCs [Suzaku I]
		Session 8	Special Non-Volatile Memories [Suzaku II]
		Session 9	Data Interconnect Technology [Suzaku III]
	19:00-21:00	Joint Dinner	
Wednesday, June 17	8:00-17:00	Registration	
	8:45-10:05	Session 10	Plenary Session II [Suzaku I, II]
	10:30-12:35	Session 11	Reliability and Security [Suzaku I]
		Session 12	Clock Generators [Suzaku III]
	12:35-14:20	Lunch	Luncheon Talk [Suzaku II](12:45-14:05)
	14:20-16:00	Session 13	DRAM and Interface [Suzaku I]
		Session 14	Discrete-Time Analog [Suzaku III]
	16:15-17:55	Session 15	SRAMS and Clock Circuits [Suzaku I]
		Session 16	DC-DC Converters [Suzaku III]
	20:00-22:00	Rump Sessions [Suzaku I, II, III]	
		Special Evening Session	
Thursday, June 18	8:00-15:00	Registration	
	8:30-10:10	Session 17	Image Sensors [Suzaku I]

		Session 18	Frequency Synthesizers [Suzaku II]
		Session 19	Power Management and High-Efficiency Logic [Suzaku III]
	10:30-12:10	Session 20	Analog Techniques [Suzaku I]
		Session 21	Advanced Equalizers [Suzaku II]
		Session 22	Clock Generation Techniques [Suzaku III]
	12:10-13:30	Lunch	
	13:30-15:10	Session 23	Low Power ADCs [Suzaku I]
		Session 24	MM-Wave Techniques [Suzaku II]
		Session 25	Media Processor Architecture [Suzaku III]
	15:25-17:05	Session 26	High-Speed ADCs [Suzaku I]
		Session 27	Wireless Transceivers [Suzaku II]
		Session 28	Signal Processing [Suzaku III]

PROGRAM

Tuesday, June 16

Session 1		Welcome and Plenary Session I [Suzaku I, II]
Chairpersons		M. Mizuno, <i>NEC Corp.</i> A. Amerasekera, <i>Texas Instruments</i>
8:30	1-1	Welcome and Opening Remarks
		K. Yano, <i>Hitachi, Ltd.</i> K. Nakamura, <i>Analog Devices, Inc.</i>
8:45	1-2	Challenges in Nanoelectronics: Dream or Reality?
Invited		N. Yokoyama, <i>Fujitsu Laboratories Ltd.</i>
9:25	1-3	Creating Support Circuits for the Brain: VLSI for Brain Machine Interfacing
Invited		T. Denison, <i>Medtronic, Inc.</i>

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(Break 10:05-10:30)

Tuesday, June 16

Session 2		CDRs and Limiting Amplifiers [Suzaku I]
Chairpersons		J. Lee, <i>National Taiwan Univ.</i> K. Chang, <i>Rambus Inc.</i>
10:30	2-1	A 2 x 22Gb/s SFI5.2 CDR/Deserializer in 65nm CMOS Technology
Abstract	N. Nedovic*, S. Parikh*, A. Kristensson*, N. Tzartzanis*, W. Walker*, S. Reddy*, H. Tamura**, S. McLeod*, T. Yamamoto**, Y. Doi**, J. Ogawa**, M. Kibune**, T. Shibasaki**, T. Hamada**, Y. Tomita**, T. Ikeuchi****,***** and N. Kuwata****,*****	
	*Fujitsu Laboratories of America,USA, **Fujitsu Laboratories Ltd., ***Fujitsu Ltd. and ****OITDA, Japan	

10:55	2-2	Adaptation of CDR and Full Scale Range of ADCBased SerDes Receiver
Abstract		E.-H. Chen*, W. Leven**, N. Warke**, A. Joy***, S. Hubbins**, A. Amerasekera** and C.-K. K. Yang*
		*University of California, Los Angeles, **Texas Instruments, Dallas, USA and ***Texas Instruments, Northampton, United Kingdom
11:20	2-3	A Reference-Free, Digital Background Calibration Technique for Gated-Oscillator-Based CDR/PLL
Abstract		C.-F. Liang, S.-C. Hwu, Y.-H. Tu, Y.-L. Yang and H.-S. Li
		MediaTek, Taiwan
11:45	2-4	A Digital Offset-Compensation Scheme for an LA and CDR in 65-nm CMOS
Abstract		S. McLeod*, A. Sheikholeslami*, T. Yamamoto**, N. Nedovic***, H. Tamura** and W.W. Walker***
		*University of Toronto, Canada, **Fujitsu Laboratories Limited, Japan and ***Fujitsu Laboratories of America, USA
12:10	2-5	A 10-Gb/s Burst-Mode Limiting Amplifier Using a Two-Stage Active Feedback Circuit
Abstract		M. Nogawa, K. Nishimura, J. Terada, M. Nakamura, S. Nishihara and Y. Ohtomo
		Nippon Telegraph and Telephone Corporation, Japan

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(Lunch 12:35-13:55)

Tuesday, June 16

Session 3		Non-Volatile and Fuse Memories [Suzaku II]
Chairpersons		H. Yamauchi, <i>Fukuoka Institute of Technology</i> G. Lehmann, <i>Infineon Technologies AG</i>
10:30	3-1	Multi-Stacked 1G Cell/Layer Pipe-Shaped BiCS Flash Memory
Abstract		T. Maeda, K. Itagaki, T. Hishida, R. Katsumata, M. Kito, Y. Fukuzumi, M. Kido, H. Tanaka, Y. Komori, M. Ishiduki, J. Matsunami, T. Fujiwara, H. Aochi, Y. Iwata and Y. Watanabe
		Toshiba Corporation, Semiconductor Company, Japan
10:55	3-2	Dynamic Vpass ISPP Scheme and Optimized Erase Vth Control for High Program Inhibition in MLC NAND Flash Memories
Abstract		K.-T. Park, M. Kang, S. Hwang, Y. Song, J. Lee, H. Joo, H.-S. Oh, J.-h. Kim, Y.-t. Lee, C. Kim and W. Lee
		Samsung Electronics Co., Ltd., Korea
11:20	3-3	Digital Rosetta Stone: A Sealed Permanent Memory with Inductive-Coupling Power and Data Link
Abstract		Y. Yuxiang*, N. Miura*, S. Imai**, H. Ochi*** and T. Kuroda*
		*Keio University, **Sharp Corporation and ***Kyoto University, Japan
11:45	3-4	High-Density 3-D Metal-Fuse PROM Featuring 1.37μm^2 1T1R Bit Cell in 32nm High-k Metal-Gate CMOS Technology
Abstract		S.H. Kulkarni, Z. Chen, J. He, L. Jiang, B. Pedersen and K. Zhang
		Intel Corporation, USA
12:10	3-5	A 1.25μm^2 Cell 32Kb Electrical Fuse Memory in 32nm CMOS with 700mV Vddmin and Parallel/Serial Interface
		S. Chung, T.-W. Chung, P.-Y. Ker and F.-L. Hsueh

Abstract	Taiwan Semiconductor Manufacturing Corp., Taiwan
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(Lunch 12:35-13:55)

Tuesday, June 16

Session 4		Biomedical and Personal Technology [Suzaku III]
Chairpersons		S. Mutoh, <i>NTT Corp.</i> T. Kwan, <i>Broadcom Corp.</i>
10:30	4-1	Asymmetric RF Tags for Ingestible Medication Compliance Capsules
Abstract		H. Yu, C.-M. Tang and R. Bashirullah <i>University of Florida, USA</i>
10:55	4-2	A 490uW Fully MICS Compatible FSK Transceiver for Implantable Devices
Abstract		J. Bae, N. Cho and H.-J. Yoo <i>KAIST, Korea</i>
11:20	4-3	A Super-Regenerative ASK Receiver with $\Delta\Sigma$ Pulse-Width Digitizer and SAR-Based Fast Frequency Calibration for MICS Applications
Abstract		Y.-H. Liu, H.-H. Liu and T.-H. Lin <i>National Taiwan University, Taiwan</i>
11:45	4-4	A 0.2mm², 27Mbps 3mW ADC/FFT-Less FDM BAN Receiver with Energy Exploitation Capability
Abstract		H. Ishizaki and M. Mizuno <i>NEC Corporation, Japan</i>
12:10	4-5	A Dynamic Real-Time Capacitor Compensated Inductive Coupling Transceiver for Wearable Body Sensor Network
Abstract		S. Lee, J. Yoo, H. Kim and H.-J. Yoo <i>KAIST, Korea</i>

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(Lunch 12:35-13:55)

Tuesday, June 16

Session 5		Transmitters and Receivers [Suzaku I]
Chairpersons		C. Kim, <i>Samsung Electronics Co.,Ltd.</i> J. Wieser, <i>National Semiconductor Corp.</i>
13:55	5-1	A 0.6mW/Gbps, 6.4-8.0Gbps Serial Link Receiver Using Local Injection-Locked Ring Oscillators in 90nm CMOS
Abstract		K. Hu*, T. Jiang*, J. Wang*, F. O'Mahony** and P.Y. Chiang* <i>*Oregon State University and **Intel Corporation, USA</i>
14:20	5-2	A 40-Gb/s Transmitter with 4:1 MUX and Subharmonically Injection-Locked CMU in 90-nm CMOS Technology
Abstract		H. Wang and J. Lee <i>National Taiwan University, Taiwan</i>
14:45	5-3	A 21-Gb/s 87-mW Transceiver with FFE/DFE/Linear Equalizer in 65-nm CMOS Technology

Abstract	H. Wang*, C.-C. Lee**, A.-M. Lee** and J. Lee*	
	*National Taiwan University and **Realtek Semiconductor Corp., Taiwan	
15:10	5-4	A 12-Gb/s Transceiver in 32-nm Bulk CMOS
Abstract	S. Joshi, J. T.-S. Liao, Y. Fan, S. Hyvonen, M. Nagarajan, J. Rizk, H.-J. Lee and I. Young	
	Intel Corporation, USA	
15:35	5-5	Self-Calibrating Transceiver for Source Synchronous Clocking System with On-Chip TDR and Swing Level Control Scheme
Abstract	Y.-C. Jang, J.-Y. Park, S. Shin, H. Choi, K. Lee, B. Woo, H. Park, W.-S. Kim, Y. Choi, J. Kim, H.-K. Kim, J. Kim, S. Lim, S.-J. Chung, S. Kim, J. Yoo and C. Kim	
	Samsung Electronics Co., LTD, Korea	

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(Break 16:00-16:10)

Tuesday, June 16

Session 6		Biomedical and Sensors [Suzaku III]
Chairpersons		K. Nakahara, <i>Sharp Corp.</i> J. Dawson, <i>Massachusetts Institute of Technology</i>
13:55	6-1	A 190μW-915MHz Active Neural Transponder with 4-Channel Time Multiplexed AFE
Abstract	Z. Xiao, C.-M. Tang, C.-C. Peng, H. Yu and R. Bashirullah	
	University of Florida, USA	
14:20	6-2	A 2.6-μW Sub-Threshold Mixed-Signal ECG SoC
Abstract	S. C. Jocke, J. F. Bolus, S. N. Wooters, A. D. Jurik, A. C. Weaver, T. N. Blalock and B. H. Calhoun	
	University of Virginia, USA	
14:45	6-3	A Micro-Power EEG Acquisition SoC with Integrated Seizure Detection Processor for Continuous Patient Monitoring
Abstract	N. Verma, A. Shueb, J.V. Guttag and A.P. Chandrakasan	
	Massachusetts Institute of Technology, USA	
15:10	6-4	A CMOS Accelerometer Using Bondwire Inertial Sensing
Abstract	Y.-T. Liao, W. Biederman and B. Otis	
	University of Washington, USA	

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(Break 15:35-16:10)

Tuesday, June 16

Special Session		Technology Highlights [Shunju I, II]
Chairpersons		S.S. Chung, <i>National Chiao Tung Univ.</i> K. Schroefer, <i>Infineon Technologies AG</i>
13:55	T7-1	Pipe-Shaped BiCS Flash Memory with 16 Stacked Layers and Multi-Level-Cell Operation for Ultra High Density Storage Devices
		R. Katsumata*, M. Kito*, Y. Fukuzumi*, M. Kido*, H. Tanaka*, Y. Komori*, M. Ishiduki*, J. Matsunami*, T. Fujiwara*, Y. Nagata***, L. Zhang**, Y. Iwata*, R. Kirisawa*, H. Aochi* and A. Nitayama*
		*Toshiba Corporation, Semiconductor Company,**Toshiba Corporation and ***Toshiba

		Information Systems (Japan) Corporation, Japan
14:20	T7-2	Extremely Scaled Gate-First High-k/Metal Gate Stack with EOT of 0.55 nm Using Novel Interfacial Layer Scavenging Techniques for 22nm Technology Node and Beyond
		K. Choi*, H. Jagannathan**, C. Choi***, L. Edge**, T. Ando***, M. Frank***, P. Jamison***, M. Wang***, E. Cartier***, S. Zafar***, J. Bruley***, A. Kerber*, B. Linder***, A. Callegari***, Q. Yang***, S. Brown***, J. Stathis***, J. Iacoponi*, V. Paruchuri** and V. Narayanan***
		*Advanced Micro Devices, Inc., **IBM Research Division and ***IBM Research Division, T.J. Watson Research Center, USA
14:45	T7-3	High Performance 32nm SOI CMOS with High-k/ Metal Gate and 0.149μm^2 SRAM and Ultra Low-k Back End with Eleven Levels of Copper
		B. Greene*, Q. Liang*, K. Amarnath**, Y. Wang*, J. Schaeffer***, M. Cai*, Y. Liang*, S. Saroop*, J. Cheng**, A. Rotondaro*, S.-J. Han*, R. Mo*, K. McStay*, S. Ku*, R. Pal**, M. Kumar*, B. Dirahoui*, B. Yang**, F. Tamweber*, W.-H. Lee*, M. Steigerwalt*, H. Weijtmans**, J. Holt*, L. Black**, S. Samavedam***, M. Turner***, K. Ramani**, D. Lee**, M. Belyansky*, M. Chowdhury***, D. Aimé***, B. Min***, H. van Meer**, H. Yin*, K. Chan*, M. Angyal*, M. Zaleski***, O. Ogunsola*, C. Child**, L. Zhuang*, H. Yan*, D. Permana**, J. Sleight*, D. Guo*, S. Mittl*, D. Ioannou*, E. Wu*, M. Chudzik*, D.-G. Park*, D. Brown**, S. Luning**, D. Mocuta*, E. Maciejewski*, K. Henson* and E. Leobandung*
		*IBM Semiconductor Research and Development Center (SRDC), **Advanced Micro Devices Inc, ***Freescale Semiconductor, USA
15:10	T7-4	Characteristics of sub 5nm Tri-Gate Nanowire MOSFETs with Single and Poly Si Channels in SOI Structure
		S.D. Suk, M. Li, Y.Y. Yeoh, K.H. Yeo, J. K. Ha, H. Lim, H.W. Park, D.-W. Kim, T.Y. Chung, K.S. Oh and W.-S. Lee
		Samsung Electronics Co., Korea

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(Break 15:35-16:10)

Tuesday, June 16

Session 7		Sigma-Delta ADCs [Suzaku I]
Chairpersons		M. Song, <i>Dongguk Univ.</i> U.-K. Moon, <i>Oregon State Univ.</i>
16:10	7-1	A 5th-Order Delta-Sigma Modulator with Single- Opamp Resonator
Abstract		K. Matsukawa*, Y. Mitani*, M. Takayama*, K. Obata*, S. Dosho* and A. Matsuzawa**
		*Panasonic Corporation and **Tokyo Institute of Technology, Japan
16:35	7-2	A 500kHz-10MHz Multimode Power-Performance Scalable 83-to-67dB DR CT$\Delta\Sigma$ in 90 nm Digital CMOS with Flexible Analog Core Circuitry
Abstract		P. Crombez*, G. Van der Plas*, M. Steyaert** and J. Craninckx*
		*IMEC and **ESAT-MICAS, Belgium
17:00	7-3	Technology Portable, 0.04mm², Ghz-Rate $\Sigma\Delta$ Modulators in 65nm and 45nm CMOS
Abstract		R.H.M. van Veldhoven, N. Nizza and L.J. Breems
		NXP Semiconductor, The Netherlands
17:25	7-4	A 79dB 80MHz 8X-OSR Hybrid Delta- Sigma/Pipeline ADC
		O. Rajae*, T. Musah*, S. Takeuchi**, M. Aniya**, K. Hamashita**, P. Hanumolu* and U. Moon*

(Joint Dinner 19:00-21:00)

Tuesday, June 16

Session 8		Special Non-Volatile Memories [Suzaku II]
Chairpersons		S.C. Chung, <i>TSMC</i> O. Jungroth, <i>Intel Corp.</i>
16:10	8-1	Ferroelectric(Fe)-NAND Flash Memory with Non- Volatile Page Buffer for Data Center Application Enterprise Solid-State Drives (SSD)
Abstract		T. Hatanaka*, R. Yajima*, T. Horiuchi**, S. Wang**, X. Zhang**, M. Takahashi**, S. Sakai** and K. Takeuchi*
		*The University of Tokyo and **National Institute of Advanced Industrial Science and Technology, Japan
16:35	8-2	Fabrication of a Nonvolatile Lookup-Table Circuit Chip Using Magneto/Semiconductor-Hybrid Structure for an Immediate-Power-Up Field Programmable Gate Array
Abstract		D. Suzuki*, M. Natsui*, S. Ikeda*, H. Hasegawa*, K. Miura***, J. Hayakawa**, T. Endoh*, H. Ohno* and T. Hanyu*
		*Tohoku University and **Hitachi, Ltd., Japan
17:00	8-3	A 5ns Fast Write Multi-Level Non-Volatile 1 K Bits RRAM Memory with Advance Write Scheme
Abstract		S.-S. Sheu***, P.-C. Chiang*, W.-P. Lin*, H.-Y. Lee*,****, P.-S. Chen***, Y.-S. Chen*, T.-Y. Wu*, F.T. Chen*, K.-L. Su*, M.-J. Kao*, K.-H. Cheng** and M.-J. Tsai*
		*ITRI, **National Central University, ***MingShin University of Science & Technology and ****National Tsing Hua University, Taiwan
17:25	8-4	32-Mb 2T1R SPRAM with Localized Bi-Directional Write Driver and '1'/'0' Dual-Array Equalized Reference Cell
Abstract		R. Takemura*, T. Kawahara*, K. Miura***, H. Yamamoto***, J. Hayakawa*, N. Matsuzaki*, K. Ono*, M. Yamanouchi*, K. Ito*, H. Takahashi*, S. Ikeda**, H. Hasegawa***, H. Matsuoka* and H. Ohno**
		*Hitachi, Ltd. and **Tohoku University, Japan

(Joint Dinner 19:00-21:00)

Tuesday, June 16

Session 9		Data Interconnect Technology [Suzaku III]
Chairpersons		H. Kabuo, <i>Panasonic Corp.</i> J. Holst, <i>Cisco Systems</i>
16:10	9-1	Crosstalk-Aware PWM-Based On-Chip Global Signaling in 65nm CMOS
Abstract		J.-s. Seo, D. Sylvester and D. Blaauw
		University of Michigan, USA
16:35	9-2	A Simultaneous Tri-Band On-Chip RF-Interconnect for Future Network-on-Chip
Abstract		S.-W. Tam, E. Socher, A. Wong and M.-C.F. Chang
		University of California Los Angeles, USA

17:00	9-3	A 4.7Gb/s Inductive Coupling Interposer with Dual Mode Modem
Abstract		S. Kawai, H. Ishikuro and T. Kuroda
		<i>Keio University, Japan</i>
17:25	9-4	A Scalable 3D Processor by Homogeneous Chip Stacking with Inductive-Coupling Link
Abstract		Y. Kohama, Y. Sugimori, S. Saito, Y. Hasegawa, T. Sano, K. Kasuga, Y. Yoshida, K. Niitsu, N. Miura, H. Amano and T. Kuroda
		<i>Keio University, Japan</i>

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(Joint Dinner 19:00-21:00)

Wednesday, June 17

Session 10		Plenary Session II [Suzaku I, II]
Chairpersons		M. Mizuno, <i>NEC Corp.</i> A. Amerasekera, <i>Texas Instruments</i>
8:45	10-1	Future of Mobile Devices - Challenges for Energy Efficient Sensing, Computing and Communication
Invited		T. Rynahen, <i>Nokia Strategic Research</i>
9:25	10-2	A Human - Area Networking Technology as a Universal Interface – Communication through Natural Human Actions: Touching, Holding, Stepping –
Invited		Y. Kado, <i>NTT Microsystem Integration Laboratories</i>

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(Break 10:05-10:30)

Wednesday, June 17

Session 11		Reliability and Security [Suzaku I]
Chairpersons		K. Kobayashi, <i>Kyoto Univ.</i> A. Bhavnagarwala, <i>IBM TJ Watson Research Center</i>
10:30	11-1	An All-In-One Silicon Odometer for Separately Monitoring HCI, BTI, and TDDB
Abstract		J. Keane, D. Persaud and C.H. Kim
		<i>University of Minnesota, USA</i>
10:55	11-2	Post-Silicon Tuning Capabilities of 45nm Low- Power CMOS Digital Circuits
Abstract		M. Meijer*, B. Liu**, R. van Veen* and J.P. de Gyvez*,**
		<i>*NXP Semiconductors and **Technical University of Eindhoven, The Netherlands</i>
11:20	11-3	Tunable Replica Circuits and Adaptive Voltage- Frequency Techniques for Dynamic Voltage, Temperature, and Aging Variation Tolerance
Abstract		J. Tschanz, K. Bowman, P.S. Walstra, M. Agostinelli, T. Karnik and V. De
		<i>Intel, USA</i>
11:45	11-4	Tunable Duplex LSIs Achieved by Multiple Phase- Modulated Clocks Capable of Predicting Delay- Increase and -Decrease Faults
Abstract		Y. Kameda and M. Mizuno
		<i>NEC Corporation, Japan</i>

12:10	11-5	Silicon Physical Unclonable Function Resistant to a 10^{25}-Trial Brute Force Attack in 90 nm CMOS
Abstract		S. Stanzione and G. Iannaccone
		<i>Università di Pisa, Italy</i>

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(Lunch 12:35-14:20)

Wednesday, June 17

Session 12		Clock Generators [Suzaku III]
Chairpersons		S. Doshio, <i>Panasonic Corp.</i> J. Barth, <i>IBM Microelectronics</i>
10:30	12-1	Multi-Decade Carrier Generation for Cognitive Radios
Abstract		B. Razavi
		<i>University of California, Los Angeles, USA</i>
10:55	12-2	A 1.3GHz 350mW Hybrid Direct Digital Frequency Synthesizer in 90nm CMOS
Abstract		H.C. Yeoh, J.-H. Jung, Y.-H. Jung and K.-H. Baek
		<i>Chung-Ang University, Korea</i>
11:20	12-3	A Bandwidth Tracking Technique for a 65nm CMOS Digital Phase-Locked Loop
Abstract		P.-H. Hsieh, J. Maxey* and C.-K. Ken Yang
		<i>University of California, Los Angeles and *Texas Instruments, USA</i>
11:45	12-4	CMOS Frequency Generation System for W-Band Radars
Abstract		N. Zhang and K.K. O
		<i>Univ. of Florida, USA</i>
12:10	12-5	A 5GHz Phase-Locked Loop Using Dynamic Phase-Error Compensation Technique for Fast Settling in 0.18-μm CMOS
Abstract		W.-H. Chiu, Y.-H. Huang and T.-H. Lin
		<i>National Taiwan University, Taiwan</i>

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(Lunch 12:35-14:20)

Wednesday, June 17,

12:45-14:05 (Separate Registration Required)

Luncheon Talk [Suzaku II]	
The Series N700 and the Tokaido Shinkansen K. Hayakawa, <i>Central Japan Railway Company</i> Does the term “eco-business trip” sound familiar? Tokaido Shinkansen is an extremely environmentally friendly mode of transportation and with the debut of the Series N700 this friendliness has been bettered further. As a way to deal with global warming, we are promoting “eco-business trips”: the selection of environmentally friendly mode of transport for business trips to reduce the emission of greenhouse gases. The history of Tokaido Shinakansen rolling stock is a history of epoch-making events. The inauguration of the Tokaido Shinakansen in 1964 with the Series 0, needless to say, is the first high-speed railway in the world. With the debut of the Series 300 in 1992, we managed to adopt the bolsterless bogie and to reduce the weight of the train-set by almost 200 tons. It is with this series that we managed to increase the maximum operating speed from 220km/h to 270km/h. Then came the Series 700 in 1999, with which we managed to	

better ride comfort significantly by using new vibration damping technology. And finally in July 2007 came the truly energy efficient Series N700. The first Shinkansen rolling stock equipped with the body inclining system that allows it to travel through curves without decreasing speed.

This talk will center on the aspects of the Series N700 while touching on the characteristics and history of the Tokaido Shinkansen.



*To register for the Luncheon Talk please refer to the registration form for fee information.

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Wednesday, June 17

Session 13		DRAM and Interface [Suzaku I]
Chairpersons		K. Kajigaya, <i>Elpida Memory, Inc.</i> M. Clinton, <i>Texas Instruments</i>
14:20	13-1	A 31ns Random Cycle VCAT-Based 4F² DRAM with Enhanced Cell Efficiency
Abstract		K.-W. Song, J.-Y. Kim, H. Kim, H.-W. Chung, H. Kim, K. Kim, H.-W. Park, H.C. Kang, S. Kim, N.-k. Tak, D. Park, W.-S. Kim, Y.-T. Lee, Y.C. Oh, G.-Y. Jin, J. Yoo, K. Oh, C. Kim and W.-S. Lee <i>Samsung Electronics Co., Korea</i>
14:45	13-2	A Sub-0.9V Logic-Compatible Embedded DRAM with Boosted 3T Gain Cell, Regulated Bit-Line Write Scheme and PVT-Tracking Read Reference Bias
Abstract		K.C. Chun, P. Jain, J.H. Lee* and C.H. Kim <i>University of Minnesota, USA and *Samsung Electronics, Korea</i>
15:10	13-3	A 4.3GB/s Mobile Memory Interface With Power- Efficient Bandwidth Scaling
Abstract		R. Palmer, J. Poulton, B. Leibowitz, Y. Frans, S. Li, A. Fuller, J. Eyles, J. Wilson, M. Aleksic, T. Greer, M. Bucher and N. Nguyen <i>Rambus Inc., USA</i>
15:35	13-4	Wide-Range Fast-Lock Duty-Cycle Corrector with Offset-Tolerant Duty-Cycle Detection Scheme for 54nm 7Gb/s GDDR5 DRAM Interface
Abstract		D. Shin, K.-J. Na, D. Kwon, J.-H. Kang, T. Song, H.-D. Jung, W.-Y. Lee, K.-C. Park, J.-H. Park, Y.-S. Joo, J.-H. Cha, Y. Jung, Y. Kim, D. Han, B.-J. Choi, G.-I. Lee, J.-H. Cho and Y.-J. Choi <i>Hynix Semiconductor Inc., Korea</i>

(Break 16:00-16:15)

Wednesday, June 17

Session 14		Discrete-Time Analog [Suzaku III]
Chairpersons		K. Agawa, <i>Toshiba Corp.</i> B. Nauta, <i>Univ. of Twente</i>
14:20	14-1	A Highly Reconfigurable 400-1700MHz Receiver Using a Down-Converting Sigma-Delta A/D with 59-dB SNR and 57-dB SFDR Over 4-MHz Bandwidth
Abstract		R. Winoto and B. Nikolić <i>University of California, Berkeley, USA</i>
14:45	14-2	A RF Receiver Front-End with Adaptive Discrete-Time Charge-Transfer Filter and Passive Gain- Boosting in 90nm CMOS
Abstract		M.-C. Lee, K. Muhammad and C.-M. Hung <i>Texas Instruments, USA</i>
15:10	14-3	A 1.28mW 100Mb/s Impulse UWB Receiver with Charge-Domain Correlator and Embedded Sliding Scheme for Data Synchronization
Abstract		L. Liu, T. Sakurai and M. Takamiya <i>The University of Tokyo, Japan</i>
15:35	14-4	A 73.1dB SNDR Digitally Assisted Sub sampler for RF Power Amplifier Linearization Systems
Abstract		S.W. Chung and J.L. Dawson <i>Massachusetts Institute of Technology, USA</i>

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(Break 16:00-16:15)

Wednesday, June 17

Session 15		SRAMS and Clock Circuits [Suzaku I]
Chairpersons		M. Yamaoka, <i>Hitachi, Ltd.</i> M. Whately, <i>Cypress Semiconductor</i>
16:15	15-1	A 45nm 24MB On-Die L3 Cache for the 8-Core Multi-Threaded Xeon® Processor
Abstract		J. Chang, S.-L. Chen, W. Chen, S. Chiu, R. Faber, R. Ganesan, M. Grgek, V. Lukka, W.W. Mar, J. Vash, S. Rusu and K. Zhang <i>Intel Corporation, USA</i>
16:40	15-2	Clock Generation & Distribution for a 45nm, 8- Core Xeon® Processor with 24MB Cache
Abstract		S. Tam, J. Leung and R. Limaye <i>Intel Corporation, USA</i>
17:05	15-3	A Differential Data Aware Power-Supplied (D²AP) 8T SRAM Cell with Expanded Write/Read Stabilities for Lower VDDmin Applications
Abstract		M.-F. Chang*, J.-J. Wu*, K.-T. Chen* and H. Yamauchi** <i>*National Tsing Hua University, Taiwan and **Fukuoka Institute of Technology, Japan</i>
17:30	15-4	A 45nm 0.6V Cross-Point 8T SRAM with Negative Biased Read/Write Assist

Abstract	M. Yabuuchi, K. Nii, Y. Tsukamoto, S. Ohbayashi, Y. Nakase and H. Shinohara
	<i>Renesas Technology Corp., Japan</i>

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Wednesday, June 17

Session 16		DC-DC Converters [Suzaku III]
Chairpersons		M. Nomura, <i>NEC Electronics Corp.</i> J. Lloyd, <i>Analog Devices</i>
16:15	16-1	20mV Input Boost Converter for Thermoelectric Energy Harvesting
Abstract		E. Carlson, K. Strunz and B. Otis <i>University of Washington, USA</i>
16:40	16-2	Single-Inductor Dual Buck-Boost Output (SIDBBO) Converter with Adaptive Current Control Mode (ACCM) and Adaptive Body Switch (ABS) for Compact Size and Long Battery Life in Portable Devices
Abstract		M.-H. Huang and K.-H. Chen <i>National Chiao Tung University, Taiwan</i>
17:05	16-3	A Hybrid DC-DC Converter for Sub-Microwatt Sub-1V Implantable Applications
Abstract		M. Wieckowski, G.K. Chen, M. Seok, D. Blaauw and D. Sylvester <i>University of Michigan, USA</i>
17:30	16-4	High-Efficiency, 12V-to-1.5V DC-DC Converter Realized with Switched-Capacitor Architecture
Abstract		V.W. Ng, M.D. Seeman and S.R. Sanders <i>University of California, Berkeley, USA</i>

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Wednesday, June 17

20:00

Rump Sessions	
R-1	Special Evening Session: “Energy Efficiency: How is ‘Green’ Implemented in Reality?” [Suzaku I, II]
Organizers	M. Takamiya, <i>The Univ. of Tokyo</i> G. Van der Plas, <i>IMEC</i>
Moderator	M. Nomura, <i>NEC Electronics Corp.</i>
Speakers	“Doing Nothing Well” J. Rabaey, <i>Univ. of California, Berkeley</i> “Vibration-Driven Energy Harvesting Using High-Performance Polymer Electret” Y. Suzuki, <i>The Univ. of Tokyo</i> “Energy Harvesting for Green Electronics” P. Mitcheson, <i>Imperial College</i> “Wearable Green SoC - Beyond Portable Low Power SoC” H.-J. Yoo, <i>KAIST</i>
In today’s world, green is everywhere. Energy efficiency is a critical feature of any system. In this session, 4 experts will give an overview of state-of-the-art techniques that are used today to implement energy efficient systems. These techniques will proliferate to more and more systems in the future.	

Topics that will be covered include energy scavenging, efficient power conversion techniques and design techniques for efficient circuits and systems. Energy scavenging from the environment is the ultimate energy efficiency. These devices and their associated power converters will be discussed in detail. Sensor interface systems and efficient wireless circuits found in, for instance, body sensor systems are an excellent example of energy efficient system design and will also be covered.

Attending this session will give you a broad view on how green electronics are realized today and in the future.

R-2	32nm SoC and Beyond - Reliable or Not? [Suzaku III]
Organizers	M. Takamiya, <i>The Univ. of Tokyo</i> K. Chang, <i>Rambus Inc.</i>
Moderator	S. Borkar, <i>Intel Corp.</i>
Panelists	D. Scott, <i>TSMC</i> S. Yamamichi, <i>NEC Corp.</i> J. Warnock, <i>IBM Corp.</i> J. Stinson, <i>Intel Corp.</i> Y. Urakawa, <i>Toshiba Corp.</i> S. Mitra, <i>Stanford Univ.</i> *Please be informed that the Paelists has been changed from the Advance Program.

Moore's law continues to push us to the 32nm regime for billion transistor SoCs. This causes major concerns in reliability and dependability due to increase in process variability, and design/architecture complexity. Where are the major bottlenecks for achieving high yield and low product return on 32nm SoCs? Which is more important - system architecture, circuit design, manufacturing, modeling, package design, test, or perhaps all? This panel discusses different aspects of the design world and tries to identify who should take a bigger role and assume more responsibility in solving the reliability problems of migration to 32nm and beyond.

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Monday, June 15

Joint Rump Session with Technology	
J-R	Is TSV 3D LSI's and Packaging Finally Ready or Is It Just Another Fantasy? [Suzaku I, II]
Organizers	M. Takamiya, <i>The Univ. of Tokyo</i> M. Clinton, <i>Texas Instruments, Inc</i> K. Schroefer, <i>Infineon Technologies AG</i> K-W. Lee, <i>Tohoku Univ.</i>
Moderator	M. Koyanagi, <i>Tohoku Univ.</i> S. Arkalgud, <i>SEMATECH</i>
Panelists	S. Borkar, <i>Intel Corp.</i> J. Knickerbocker, <i>IBM Corp.</i> L. Durodami, <i>Qualcomm Inc.</i> T. Kuroda, <i>Keio Univ.</i> C. Berry, <i>Amkor Technology</i> B. Haba, <i>Tessera Inc.</i>
3D LSI integration and packaging have been discussed for decades. Is TSV just the latest buzz-word or will it become a mainstream process? The panel will discuss which applications (memory, processor, memory+processor, imager, mixed-signal, FPGA or others) are driving the development of TSV and what types of applications could benefit from TSV in the future. The panel will debate how these applications get an advantage in the marketplace from TSV, which they cannot get from other 3D LSI integration or packaging technologies in manufacturing today. We have assembled a distinguished panel of experts who will discuss and debate these questions and more as they explore the prospects of TSV for 3D LSI and packaging. - Does TSV offer design, test, performance, yield, thermal / power or cost advantages over existing 3D technologies? - What are main challenges and limitations for the acceptance in mainstream applications? - Who will offer TSV as a design solution; IDM's, Foundries and/or OSAT's?	

*This session will be held at 20:00-22:00 on Monday, June 15.

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Thursday, June 18

Session 17		Image Sensors [Suzaku I]
Chairpersons		M. Ikeda, <i>The Univ. of Tokyo</i> V. De, <i>Intel Corp.</i>
8:30	17-1	A 0.45-0.7V Sub-Microwatt CMOS Image Sensor for Ultra-Low Power Applications
Abstract		S. Hanson and D. Sylvester <i>University of Michigan, USA</i>
8:55	17-2	A 0.75V CMOS Image Sensor Using Time-Based Readout Circuit
Abstract		K. Cho, D. Lee, J. Lee and G. Han <i>Yonsei University, Korea</i>
9:20	17-3	A Color-Independent Saturation, Linear Response, Wide Dynamic Range CMOS Image Sensor With Retinal Rod-and Cone-Like Color Pixels
Abstract		S. Kawada*, S. Sakai*, N. Akahane*, K. Mizobuchi** and S. Sugawa* <i>*Tohoku University and **Texas Instruments, Japan</i>
9:45	17-4	A CMOS Image Sensor With 2.5-e⁻ Random Noise and 110-ke⁻ Full Well Capacity Using Column Source Follower Readout Circuits
Abstract		T. Kohara*, W. Lee*, N. Akahane*, K. Mizobuchi** and S. Sugawa* <i>*Tohoku University and **Texas Instruments, Japan</i>

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(Break 10:10-10:30)

Thursday, June 18

Session 18		Frequency Synthesizers [Suzaku II]
Chairpersons		M. Takamiya, <i>The Univ. of Tokyo</i> L. Breems, <i>NXP Semiconductors</i>
8:30	18-1	A Compact 0.8-6GHz Fractional-N PLL with Binary-Weighted D/A Differentiator and Offset-Frequency Δ-Σ Modulator for Noise and Spurs Cancellation
Abstract		H.-Y. Jian***, Z. Xu**, Y.-C. Wu** and F. Chang* <i>*University of California, Los Angeles and **SST Communications, USA</i>
8:55	18-2	A 320fs-RMS-Jitter and 300kHz-BW All-Digital Fractional-N PLL with Self-Corrected TDC and Fast Temperature Tacking Loop for WiMax/WLAN 11n
Abstract		H.-H. Chang, C.-H. Fu and M. Chiu <i>MediaTek Inc., Taiwan</i>
9:20	18-3	A Direct Digital Frequency Modulation PLL with All Digital On-Line Self-Calibration for Quad-Band GSM/GPRS Transmitter
Abstract		C.-H. Wang, P.-Y. Wang, L.-W. Ke, D.-Y. Yu, B.-H. Ong, C.-H. Sun, H.-H. Chen, Y.-Y. Chen, C.-M. Kuo, J.-C. Lin, T.-P. Wang and Y.-H. Chen <i>MediaTek Inc., Taiwan</i>
		A Low-Voltage, 9-GHz, 0.13-μm CMOS Frequency Synthesizer With a

9:45	18-4	Fractional Phase-Rotating and Frequency-Doubling Topology
Abstract		C.-H. Chang and C.-Y. Yang
		National Chung Hsing University, Taiwan

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(Break 10:10-10:30)

Thursday, June 18

Session 19		Power Management and High-Efficiency Logic [Suzaku III]
Chairpersons		T. Shiota, <i>Fujitsu Laboratories Ltd.</i> J. Gealow, <i>MediaTek Wireless, Inc.</i>
8:30	19-1	Multi-Phase 1GHz Voltage Doubler Charge-Pump in 32nm Logic Process
Abstract		D. Somasekhar, B. Srinivasan, G. Pandya, F. Hamzaoglu, M. Khellah, T. Karnik and K. Zhang
		Intel Corporation, USA
8:55	19-2	A 82% Efficiency 0.5% Ripple 16-Phase Fully Integrated Capacitive Voltage Doubler
Abstract		T.V. Breussegem and M. Steyaert
		ESAT-MICAS, Belgium
9:20	19-3	Dual-Power-Path RF-DC Multi-Output Power Management Unit for RFID Tags
Abstract		J. Yi, W.-H. Ki, P. K.T. Mok and C.-Y. Tsui
		The Hong Kong University of Science and Technology, China
9:45	19-4	A 187MHz Subthreshold-Supply Robust FIR Filter with Charge-Recovery Logic
Abstract		W.-H. Ma*, J.C. Kao*, V.S. Sathe*,** and M. Papaefthymiou*
		*University of Michigan and **Advanced Micro Devices, USA

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(Break 10:10-10:30)

Thursday, June 18

Session 20		Analog Techniques [Suzaku I]
Chairpersons		M. Nagata, <i>Kobe Univ.</i> A. Abidi, <i>Univ. of California, Los Angeles</i>
10:30	20-1	A 28.1dBm Class-D Outphasing Power Amplifier in 45nm LP Digital CMOS
Abstract		H. Xu, Y. Palaskas, A. Ravi, M. Sajadieh, M. Elmala and K. Soumyanath
		Intel Corporation, USA
10:55	20-2	Time Difference Amplifier Using Closed-Loop Gain Control
Abstract		T. Nakura, S. Mandai, M. Ikeda and K. Asada
		The University of Tokyo, Japan
11:20	20-3	A Chopper and Auto-Zero Offset-Stabilized CMOS Instrumentation Amplifier
Abstract		J.F. Witte, J.H. Huijsing and K.A.A. Makinwa

		<i>Delft University of Technology, The Netherlands</i>
11:45	20-4	Complex IIP2 Improvement Through Active Cancellation of LO Leakage
Abstract		H. Choo, K. Muhammad and M.-C. Lee
		<i>Texas Instruments Inc., USA</i>

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(Lunch 12:10-13:30)

Thursday, June 18

Session 21		Advanced Equalizers [Suzaku II]
Chairpersons		K. Nose, <i>NEC Corp.</i> K. Chang, <i>Rambus Inc.</i>
10:30	21-1	A 19Gb/s 38mW 1-Tap Speculative DFE Receiver in 90nm CMOS
Abstract		D.Z. Turker*, A. Rylyakov**, D. Friedman**, S. Gowda** and E. Sánchez-Sinencio*
		*Texas A&M University and **IBM T.J. Watson Research Center, USA
10:55	21-2	A 40Gb/s Decision Feedback Equalizer Using Back-Gate Feedback Technique
Abstract		C.-L. Hsieh and S.-I. Liu
		<i>National Taiwan University, Taiwan</i>
11:20	21-3	A Data Pattern-Tolerant Adaptive Equalizer Using Spectrum Balancing Method
Abstract		H.-Y. Joo, K.-S. Ha and L.-S. Kim
		<i>KAIST, Korea</i>
11:45	21-4	A Fractionally Spaced Linear Receive Equalizer with Voltage-to-Time Conversion
Abstract		S. Song, B. Kim and V. Stojanović
		<i>Massachusetts Institute of Technology, USA</i>

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(Lunch 12:10-13:30)

Thursday, June 18

Session 22		Clock Generation Techniques [Suzaku III]
Chairpersons		J.-Y. Sim, <i>Pohang Univ.</i> J. Farrell, <i>AMD</i>
10:30	22-1	A 10MHz 80μW 67 ppm/°C CMOS Reference Clock Oscillator with a Temperature Compensated Feedback Loop in 0.18μm CMOS
Abstract		J. Lee and S.H. Cho
		<i>KAIST, Korea</i>
10:55	22-2	A 0.114-mW Dual-Conduction Class-C CMOS VCO with 0.2-V Power Supply
Abstract		K. Okada, Y. Nomiya, R. Murakami and A. Matsuzawa
		<i>Tokyo Institute of Technology, Japan</i>
11:20	22-3	A 132.7-to-143.5GHz Injection-Locked Frequency Divider in 65nm CMOS
		B.-Y. Lin and S.-I. Liu

Abstract		National Taiwan University, Taiwan
11:45	22-4	A 12-Bit Vernier Ring Time-to-Digital Converter in 0.13μm CMOS Technology
Abstract		J. Yu, F.F. Dai and R.C. Jaeger
		Auburn University, USA

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(Lunch 12:10-13:30)

Thursday, June 18

Session 23		Low Power ADCs [Suzaku I]
Chairpersons		A. Wada, <i>SANYO Semiconductor Co., Ltd.</i> G. Van der Plas, <i>IMEC</i>
13:30	23-1	A 0.92mW 10-Bit 50-MS/s SAR ADC in 0.13μm CMOS Process
Abstract		C.-C. Liu, S.-J. Chang, G.-Y. Huang and Y.-Z. Lin
		National Cheng Kung University, Taiwan
13:55	23-2	A 6-Bit 50-MS/s Threshold Configuring SAR ADC in 90-nm Digital CMOS
Abstract		P. Nuzzo ^{*,**} , C. Nani ^{*,***} , C. Armiento ^{*,****} , A. Sangiovanni-Vincentelli ^{**} , J. Craninckx [*] and G.V. der Plas [*]
		[*] IMEC, Belgium, ^{**} University of California at Berkeley, USA, ^{***} NXP, The Netherlands and ^{****} University of Pisa, Italy
14:20	23-3	A 12b 11MS/s Successive Approximation ADC with Two Comparators in 0.13μm CMOS
Abstract		J.J. Kang ^{*,**} and M.P. Flynn [*]
		[*] University of Michigan and ^{**} Marvell Technology Group, USA
14:45	23-4	A 1.3μW 0.6V 8.7-ENOB Successive Approximation ADC in a 0.18μm CMOS
Abstract		S.-K. Lee, S.-J. Park, Y. Suh, H.-J. Park and J.-Y. Sim
		Pohang University of Science and Technology (POSTECH), Korea

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(Break 15:10-15:25)

Thursday, June 18

Session 24		MM-Wave Techniques [Suzaku II]
Chairpersons		J. Lee, <i>National Taiwan Univ.</i> C.-M. Hung, <i>Texas Instruments, Inc</i>
13:30	24-1	A 77 GHz 90 nm CMOS Transceiver for FMCW Radar Applications
Abstract		T. Mitomo, N. Ono, H. Hoshino, Y. Yoshihara, O. Watanabe and I. Seto
		Toshiba Corporation, Japan
13:55	24-2	60-GHz Hybrid Transmit/Receive Switch Using p-n Diode and MOS Transistors
Abstract		C. Mao and K.K. O
		University of Florida, USA
14:20	24-3	60GHz RF-Path Phase-Shifting Two-Element Phased-Array Front-End in Silicon

Abstract		A. Natarajan*, M.-D. Tsai** and B. Floyd*
		*IBM T. J. Watson Research Center, USA and **MediaTek Inc., Taiwan
14:45	24-4	36mW 63GHz CMOS Differential Low-Noise Amplifier with 14GHz Bandwidth
Abstract		Y. Natsukari and M. Fujishima
		The University of Tokyo, Japan

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(Break 15:10-15:25)

Thursday, June 18

Session 25		Media Processor Architecture [Suzaku III]
Chairpersons		M. Igarashi, <i>Sony Corp.</i> S. Tam, <i>Intel Corp.</i>
13:30	25-1	3D System Integration of Processor and Multi- Stacked SRAMs by Using Inductive-Coupling Links
Abstract		K. Osada*, M. Saen*, Y. Okuma*, K. Niitsu**, Y. Shimazaki***, Y. Sugimori**, Y. Kohama**, K. Kasuga**, I. Nonomura***, N. Irie*, T. Hattori***, A. Hasegawa*** and T. Kuroda**
		*Hitachi, Ltd., **Keio University and ***Renesas Technology Corp., Japan
13:55	25-2	A 116fps 74mW Mobile Heterogeneous 3D-Media Processor for 3D Display Contents
Abstract		S.-H. Kim*, H.-Y. Kim*, Y.-J. Kim*, K. Chung*, D. Kim** and L.-S. Kim*
		*KAIST, Korea and **Qualcomm Inc., USA
14:20	25-3	A 22.8GOPS 2.83mW Neuro-Fuzzy Object Detection Engine for Fast Multi-Object Recognition
Abstract		M. Kim, J.-Y. Kim, S. Lee, J. Oh and H.-J. Yoo
		KAIST, Korea
14:45	25-4	A 1080p@60fps Multi-Standard Video Decoder Chip Designed for Power and Cost Efficiency in a System Perspective
Abstract		D. Zhou*, Z. You**, J. Zhu**, J. Kong**, Y. Hong**, X. Chen**, X. He**, C. Xu**, H. Zhang**, J. Zhou*, N. Deng**, P. Liu** and S. Goto*
		*Waseda University, Japan and **Shanghai Jiao Tong University, China

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(Break 15:10-15:25)

Thursday, June 18

Session 26		High-Speed ADCs [Suzaku I]
Chairpersons		M. Ito, <i>Renesas Technology Corp.</i> J. Savoj, <i>Qualcomm Inc</i>
15:25	26-1	A Self-Background Calibrated 6b 2.7GS/s ADC with Cascade-Calibrated Folding-Interpolating Architecture
Abstract		Y. Nakajima*, A. Sakaguchi*, T. Ohkido**, T. Matsumoto* and M. Yotsuyanagi*
		*NEC Electronics Corporation and **NEC Micro Systems, Japan
15:50	26-2	A 7.5-GS/s 3.8-ENOB 52-mW Flash ADC with Clock Duty Cycle Control in 65nm CMOS
		H. Chung*, A. Rylyakov**, Z.T. Deniz**, J. Bulzacchelli**, G.-Y. Wei* and D.

Abstract		Friedman**
		<i>*Harvard University and **IBM T.J. Watson Research Center, USA</i>
16:15	26-3	A 1.5-GHz 63dB SNR 20mW Direct RF Sampling Bandpass VCO-Based ADC in 65nm CMOS
Abstract		Y.-G. Yoon and S.H. Cho
		<i>KAIST, Korea</i>
16:40	26-4	A Dual-Channel 10b 80MS/s Pipeline ADC with 0.16mm² Area in 65nm CMOS
Abstract		X. Yu, F. Lin, K. Li, S. Ranganathan and T. Kwan
		<i>Broadcom Corporation, USA</i>

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Thursday, June 18

Session 27		Wireless Transceivers [Suzaku II]
Chairpersons		H. Ishikuro, <i>Keio Univ.</i> B. Nikolic, <i>Univ. of California, Berkeley</i>
15:25	27-1	528mW Zero-IF Full-Segment ISDB-T CMOS Tuner with 10th-Order Channel Filters
Abstract		T. Kamata***, K. Okui*, M. Fukasawa*, K. Tanaka*, C. Go*, N. Motoyama*, T. Matsuoka** and K. Taniguchi**
		<i>*RfStream Corporation and **Osaka University, Japan</i>
15:50	27-2	A 2×VDD-Enabled TV-Tuner RF Front-End Supporting TV-GSM Interoperation in 90nm CMOS
Abstract		P.-I. Mak* and R.P. Martins**
		<i>*University of Macau, China and **On leave from Instituto Superior Técnico (IST), Portugal</i>
16:15	27-3	A Frequency Translation Technique for SAW-Less 3G Receivers
Abstract		A. Mirzaei, X. Chen, A. Yazdi, J. Chiu, J. Leete and H. Darabi
		<i>Broadcom Corporation, USA</i>
16:40	27-4	A 4-Stream 802.11n Baseband Transceiver in 0.13 μm CMOS
Abstract		A. Burg***, S. Haene***, M. Borgmann**, D. Baum**, T. Thaler**, F. Carbognani**, S. Zwicky**, L. Barbero**, C. Senning*, P. Greisen*, **, T. Peter*, C. Foelml**, U. Schuster**, P. Tejera** and A. Staudacher
		<i>*ETH Zurich and **Celestrius AG, Switzerland</i>

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Thursday, June 18

Session 28		Signal Processing [Suzaku III]
Chairpersons		M. Hariyama, <i>Tohoku Univ.</i> K. Shepard, <i>Columbia Univ.</i>
15:25	28-1	A 47 Gb/s LDPC Decoder with Improved Low Error Rate Performance
Abstract		Z. Zhang, V. Anantharam, M.J. Wainwright and B. Nikolić
		<i>University of California, Berkeley, USA</i>
15:50	28-2	A 188-size 2.1mm² Reconfigurable Turbo Decoder Chip with Parallel Architecture for 3GPP LTE System

Abstract		C.-C. Wong, Y.-Y. Lee and H.-C. Chang
		<i>National Chiao Tung University, Taiwan</i>
16:15	28-3	A 58-μW Single-Chip Sensor Node Processor Using Synchronous MAC Protocol
Abstract		T. Takeuchi, S. Izumi, T. Matsuda, H. Lee, Y. Otake, T. Konishi, K. Tsuruda, Y. Sakai, H. Fujiwara, C. Ohta, H. Kawaguchi and M. Yoshimoto
		<i>Kobe University, Japan</i>
16:40	28-4	A 200Mbps+ 2.14nJ/b Digital Baseband Multi Processor System-on-Chip for SDRs
Abstract		V. Derudder, B. Bougard, A. Couvreur, A. Dewilde, S. Dupont, L. Folsens, L. Hollevoet, F. Naessens, D. Novo, P. Raghavan, T. Schuster, K. Stinkens, J.-W. Weijers and L. Van der Perre
		<i>IMEC, Belgium</i>

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